

Search Notes**Application/Control No.**

10/692,269

Examiner

HABTE MERED

**Applicant(s)/Patent under
Reexamination**

LIAO ET AL.

Art Unit

2416

SEARCHED

Class	Subclass	Date	Examiner
370	230	11/25/2008	HM
370	230.1	11/25/2008	HM
370	231	11/25/2008	HM
370	232	11/25/2008	HM
370	233	11/25/2008	HM
370	234	11/25/2008	HM
370	449	11/25/2008	HM
709	225-229	11/25/2008	HM
455	450	11/25/2008	HM
455	452.1	11/25/2008	HM
455	452.2	11/25/2008	HM
455	453	11/25/2008	HM

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched East DB:USPAT, USPG-Pub, EPO and JPO	11/25/2008	HM
Searched IEEE	11/25/2008	HM
Searched Palm Inventor's DB	4/25/2008	HM